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Substitute for form 1449A PTO

INFORMATION DISCLOSURE STATEMENT BY APPLICANT

(use as many sheets as necessary)

1 of 3

Complete if Known							
Application Number	09 931,268	134373					
Filing Date	August 16, 2001	1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1. 1					
First Named Inventor	Linlin Chen et al.	70[9 a 1 d					
Group Art Unit	1743						
Examiner Name	Unknown	770					
Attorney Docket Number	1921.0014C	1.77					

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		U.S. Patent	Document		Date of Publication of Cited						
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^{*}EXAMINER. Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

¹ Unique citation designation number

See attached Kinds of U.S. Patent Documents.

Enter Office that issued the document, by the two-letter code (WIPO Standard ST 3).

For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document.

Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST, 16 if possible.

Applicant is to place a check mark here if English language. Translation is attached

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mmais		Office'	Number ⁴	Kind Code ^c (if known)	Name of Patentee or Applicant of Cited Document	of Cited Document MM-DD-YYYY	Τ^
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Examiner Signature Olle Magherala Date Considered 3/30/04

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¹ For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document

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				Complete if Known				
Subs	Substitute for form 1449B PTO		Application Number	09 931.268				
				Filing Date	August 16, 2001	Eirs		
INI	INFORMATION DISCLOSURE		First Named Inventor	Linlin Chen et al.	T. C.K.			
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Sheet	3	of	3	Attorney Docket Number	1921.0014C	JAYO _{LLO}		

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		OTHER DOCUMENTS - NON PATENT LITERATURE DOCUMENTS	्या ।
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Examiner /) (No	Date	1/20/06	
Signature	r lly herela	Considered	3/3907	

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Unique citation designation number:
 Applicant is to place a check mark here if English language Translation attached.

COMPL IF KNOWN **Application Number** 09/931,268 STATEMENT BY APPLICANT INFORMATION DISCLOSURE Confirmation Number 2230 August 16, 2001 Filing Date JUN 1 9 2003 Form PTO-1449 (Modified) (Use several sheets if necessary) TADEMIN'S Sheet First Named Inventor Linlin Chen Group Art Unit 1753 Examiner Name Ta Hsung Tung 2 29195-8183US of Attorney Docket No.

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	4,917,774			Fis	sher	04/17/90	The courses	
	ļ	4,91	17,777		Fis	sher	04/17/90	retuin
	4,948,473 5,192,403 5,196,096			Phillippi		08/14/90	4/90 A\ (en)	
				Ør	nang et al.	03/09/93	E IDELES	
				Chang et al.		03/23/93 Com v	Conside	
		5,22	23,118		Sonneberg et al. Takami Carpio		03/27/79 04/17/90 04/17/90 08/14/90 03/09/93 03/23/93 06/29/93 08/10/93 11/15/94 02/14/95 03/21/95	
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		5,53	34,128		As	so et al.	07/09/96	W.
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Examiner Initials*	Cite No.	Fore	eign Patent o	r Application Kind C	Code	Name of Patentee or Applicant of Cited Document	Date of Publication or Filing Date of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		WO	99/096			Semitool, Inc.	11/11/99	
			99/579	549 AI				
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1	~ 01p				Application Number	09/931,268	
1			DISCLOSURE		Confirmation Number	2230	
1)	BY APPLICANT		Filing Date	August 16, 2001	
3	9 7003	Form PTO-1	449 (Modified)		First Named Inventor	Linlin Chen	
16	کم ''دپر ^{(ا}	Use several she	eets if necessary)	Group Art Unit	1753	
. }	TOFMARY OFFE		ets if necessary		Examiner Name	Ta Hsung Tung	
	Sheet	2	of	2	Attorney Docket No.	29195-8183US	

OTHER PRIOR ART-NON PATENT LITERATURE DOCUMENTS			
Examiner Initials*	Cite No.	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume issue number(s), publisher, city and/or country where published.	
		WILLARD et al., "Instrumental Methods of Analysis," (1974), pp 647 to 656	_
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These two references
were already considered
in the TDS

of
June 25,3003.

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